


Energy spectrum of semimetallic HgTe quantum wells

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Quantum wells (QWs) based on mercury telluride (HgTe) thin films provide a large range of unusual physical properties, from an insulator via a two-dimensional Dirac semimetal to a three-dimensional topological insulator. These properties result from the dramatic change in the QW band structure with the HgTe film thickness. Despite being a key property, these energy dispersion relations cannot be reflected in experiments due to the lack of appropriate tools. Here we report an experimental and theoretical study of two HgTe QWs with an inverted energy spectrum in which two-dimensional semimetallic states are realized. Using magneto-optical spectroscopy at subterahertz frequencies we obtain information about electron and hole cyclotron masses at all relevant Fermi level positions and different charge densities. The outcome is also supported by a Shubnikov–de Haas analysis of capacitance measurements, which allows us to obtain information on the degeneracy of the active modes. From these data, it is possible to reconstruct electron and hole dispersion relations. A detailed comparative analysis of the energy dispersion relations with theoretical calculations demonstrates a good agreement, even reflecting several subtle features like band splitting, the second conduction band, and the overlaps between the first conduction and the first valence band. Our study demonstrates that cyclotron resonance experiments can be efficiently used to directly obtain the band structures of semimetallic two-dimensional materials.

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I. INTRODUCTION

Quantum wells (QWs) based on strained HgTe films have been studied extensively in recent years, revealing numerous exotic properties [1,2]. These properties arise due to the shifts of the *s*-like E1 and *p*-like H1 and H2 bands of HgTe with the QW thickness. For a thickness below the critical $d_c \sim 6.5$ nm an energy gap opens between the H1 valence and the E1 conduction bands and an insulating state can be realized. Both bands are touching at $d = d_c$, forming a two-dimensional (2D) semimetal with zero gap and with a Dirac dispersion [3]. Further increasing the thickness leads again to an opening of a gap. However, in this case, the original E1 and H1 bands are interchanged, forming an inverted band structure and a quantum spin Hall insulator [3,4]. If a bulk HgTe layer $d \gtrsim 50$ nm is grown on a CdTe substrate, tensile strain due to lattice mismatch splits the originally degenerate light and heavy Γ_8 hole bands at the center of the Brillouin zone, forming a three-dimensional topological insulator [5,6].

HgTe wells in the thickness range of about 10–30 nm represent unique examples of 2D semimetals, where electrons and holes coexist simultaneously [7,8]. Here the H2 valence and H1 conduction bands indirectly overlap, forming a negative gap in the meV range. With a few exceptions [9], studies of HgTe quantum wells in a semimetallic state [10–15] have generally concluded that while the measured properties of the conduction band agree reasonably well with the theoretical models, the valence band spectrum does not. The

results have generally shown that the valence subbands are strongly anisotropic, forming four local maxima at nonzero k values, with an overlap of a few meV with the rotationally symmetric conduction subband. However, the mismatch between experimental data and model calculations, such as the band overlap and the hole effective mass, indicate that the theoretical approach to this problem is not fully established. Moreover, recent experiments on samples with a (013) surface orientation [15] suggest a twofold valley degeneracy of the top valence subbands.

Here we investigate two semimetallic HgTe QWs by analysis of the cyclotron resonance (CR). Applying a recently established technique [16,17] allows us to directly obtain the band structures of these 2D structures. An analysis of the Shubnikov–de Haas (SdH) oscillations [15,18–20] seen in the capacitance of the samples [21,22] provides additional insight into the properties of the charge carriers in the system, providing the degeneracies of the bands. With two experimental techniques, we are able to probe the top valence subband states, the first conduction subband, and even the second conduction subband. The experimental results of the CR analysis and magnetotransport measurements are compared with the $\mathbf{k} \cdot \mathbf{p}$ model, showing a good overlap. The combination of the bulk inversion asymmetry and the structure inversion asymmetry leads to the appearance of two hole islands in the valence subband [23,24].

II. RESULTS AND DISCUSSION

Figure 1 shows the band structure of a 2D semimetal obtained via $\mathbf{k} \cdot \mathbf{p}$ calculations as detailed in the Appendix,

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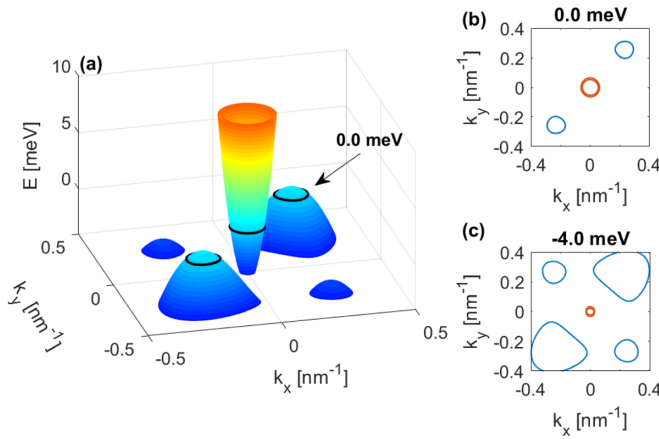


FIG. 1. Theoretical band structure of a semimetallic QW. (a) The first valence band and the first conduction band of the 14.1-nm-thick HgTe layer at the charge neutrality point with the Fermi energy of 0 meV. (b) Cross section of the band structure at $E = 0$ meV. Blue: holelike Fermi surface ($\partial A/\partial E < 0$) of the islands in the $(\pm 1, \pm 1)$ directions. Orange: electronlike Fermi surface ($\partial A/\partial E > 0$) of the conduction band. (c) Fermi surface of the hole-doped sample with $E = -4$ meV.

Sec. 5. These results confirm the rotational symmetry of the conduction bands, which allows reconstruction of the experimental band structure via integration of the simplified Eq. (A4) (see the Appendix). The valence bands in semimetallic HgTe quantum wells show strongly anisotropic behavior [15], demonstrating two pronounced maxima (“islands”) in the first valence subband, H2. As demonstrated in Fig. 1(b), at low hole concentrations, i.e., close to the band maxima, the Fermi surfaces of the islands can be reasonably well approximated by circles shifted by $\mathbf{k} = \pm(k_0, k_0)$ from the Γ point with an effective radius k_{eff} . Here, $k_0 \approx 0.25 \text{ nm}^{-1}$ for the 14.1-nm-thick sample and $k_0 \approx 0.22 \text{ nm}^{-1}$ for the 22-nm sample. In this approximation, the approach to reconstructing the energy dispersion given in Eqs. (A3) and (A4) is justified.

A. Cyclotron resonance

Figure 2 shows the spectra of the field-dependent transmission in the geometry with circularly polarized radiation for two HgTe QWs. The advantage of this geometry is the clear separation of the electron (**e**) and hole (**h**) resonances, as they are observed for positive and negative external magnetic fields, in agreement with Eq. (A1). Below $V_g = -6$ V we observe a hole CR (**h**₁) in both samples. In the entire region of the applied gate voltage we observe an electronic CR, which we denote **e**₁. In the 22-nm sample and at high frequencies [658 and 966 GHz; Fig. 2(a)], which provide a higher resolution of the cyclotron mass, we observe an additional contribution above $V_g > 9$ V, which we identify as carrier type **e**₂.

Several transmission spectra show contributions in positive fields that are symmetric with respect to the electron CR [see, for example, Fig. 2(b) at ~ 0.1 T]. We attribute them to mirror peaks of the **e**₁ CR, a consequence of non-ideally circularly polarized incident radiation. In some spectra, several antisymmetrically mirrored peaks are observed that likely correspond

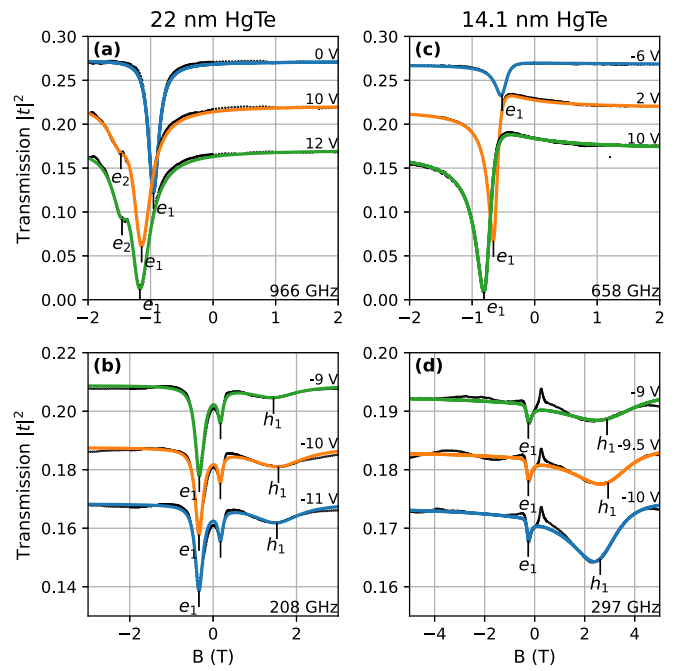


FIG. 2. Cyclotron resonance with circularly polarized light. The intensity of the transmitted radiation $|t_+|^2$ through the 22-nm (a, b) and the 14.1-nm (c, d) samples as a function of the external magnetic field for fixed frequencies, as indicated. Resonance features for positive and negative fields correspond to holes and electrons, respectively. Black points, experiment; solid lines, theoretical transmission based on the Drude conductivity, Eq. (A1). The absolute scales refer to the lowest curves; the others are shifted for clarity.

to the **e**₁ CR as well [see Fig. 2(d) between ± 0.5 T]. We suggest an admixture of the signal reflected from the backside of the substrate or admixture of the phase signal as a possible cause; the latter effect might be more pronounced for sharper peaks. A full understanding of the mechanisms behind these signatures requires further investigations.

The transmission curves can be fitted well using the procedure presented in the Appendix, Sec. 3 (solid lines in Fig. 2). From the analysis of the resonances in the transmission, we obtain the 2D charge density n_{2D} , effective cyclotron mass m_c , and scattering time τ for each carrier type.

Figure 3 shows the parameters of the CRs. Data obtained at different frequencies overlap well in the case of electrons. On the other hand, holes are characterized by heavier masses, lower carrier densities, and lower mobilities. These factors result in much weaker cyclotron signatures in the transmission spectra. The analysis of the hole CRs is affected by the noise level, time-related drifts, and other artifacts, resulting in larger fitting errors. Nevertheless, as shown in Figs. 3(d) and 3(h), all carrier types demonstrate a linear behavior of the cyclotron frequency ($\omega = 2\pi\nu$) with respect to the resonance field ($B_r = m_c\omega/e$), satisfying the quasiclassical approach in Eq. (A3). Figures 3(a) and 3(e) show a gradual increase in the effective mass of **e**₁ above ~ -5 V, reflecting the deviation of the dispersion from parabolic form. At lower voltages, the mass increases with decreasing gate until it stabilizes at around -8 V for both samples.

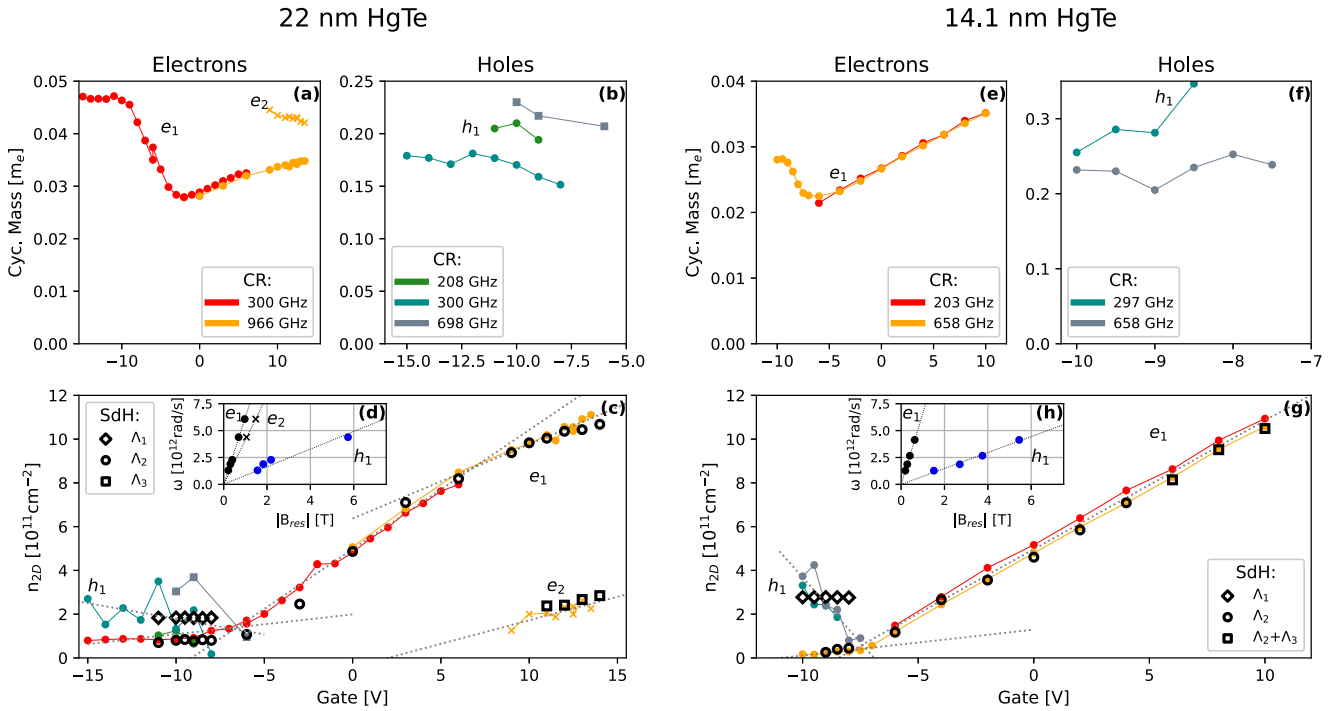


FIG. 3. Electrodynamical parameters of the cyclotron resonances in HgTe: (a–d) 22-nm HgTe sample; (e–h) 14.1-nm HgTe sample. Colored symbols represent experimental data from the fits of the spectra in Fig. 2. The dotted lines in (c) and (g) serve as guides for the eye. Open black symbols correspond to the carrier concentration resulting from the SdH analysis (see Fig. SI.2 in the Supplemental Material [25]). Insets (d, h) show the field dependence of the cyclotron resonance, demonstrating linear behavior within the quasiclassical approximation according to Eq. (A3).

The absolute values of the charge density decrease with the gate voltage for holes and increase for electrons. Both agree with the sign of the charge carrier types obtained directly from the spectra in Fig. 2. With the help of the dotted lines in Figs. 3(c) and 3(g), one can observe a sectional linear relation between the e_1 -carrier concentrations and the gate voltage. The slope $\partial n_{2D}/\partial V_g$ of e_1 changes with the emergence of the additional carrier type e_2 in the system, since the derivative of the total charge density $\partial n_{\text{tot}}/\partial V_g$ can be expected to remain constant. It is evident in Fig. 3(c) that both the sum of the slopes of e_1 and e_2 above 10 V and the sum of the slopes belonging to e_1 and h_1 below -10 V match the $\partial n_{2D}/\partial V_g$ of e_1 between -10 and 10 V. We also observe similar in the case of the thinner sample [Fig. 3(g)]. For both samples, all parameters of e_1 almost stabilize below -8 V, as in this range the electrons are weakly affected by the gate voltage. We assume this to be a consequence of the Fermi level entering the flat valence band with a high density of hole states. For further information, the mobility [10,11,26] of carrier type e_1 is discussed in Supplemental Material [25].

B. Mass vs density

Figures 4(a)–4(d) compare the density dependence of the cyclotron mass with predictions of the $\mathbf{k} \cdot \mathbf{p}$ model. By varying the total charge density n_{tot} between -7×10^{11} and 12×10^{11} cm⁻², we obtained the theoretical values of the electron (hole) charge densities by integrating over the occupied conduction (unoccupied valence) states. Knowing the positions of

the Fermi energy, the theoretical values of the cyclotron mass were determined using the quasiclassical Eq. (A3).

The reader should note that data presented in Figs. 4(a)–4(d) do not rely on the isotropic approximation argued in the Appendix, Sec. 4. This representation of the data has an additional advantage. Since the measurements took place in different cooling cycles, we cannot fully rely on the gate voltage to represent a good absolute metric of the electronic state of the samples. Moreover, we observe that applying high gate voltages (above ~ 10 V) to the sample leads to the saturation of the total charge density and results in a shift of the gate value at which the charge neutrality point is observed, i.e., the previous correspondence between the applied gate voltage and the electronic state of the sample becomes obsolete.

Experimental and theoretical data in Figs. 4(a) and 4(b) correspond to electronlike carrier types for both samples. The $\mathbf{k} \cdot \mathbf{p}$ theory predicts two spin-split states, H₁₁ and H₁₂. The mass of H₁₁ shows signs of divergence at low densities, while the mass corresponding to the H₁₂ subband remains at lower values and even drastically decreases in the 14.1-nm sample. This separation occurs due to an inversion asymmetry which results in energetic minima at very small finite k values of H1 bands. Similar behavior is also observed for the spin-split states E₂₁ and E₂₂. Although the theory predicts all electronic states to be single-degenerate with $D = 1$, it appears that the resolution of the CR experiments did not allow observation of the spin-splitting of electronic states leading to degeneracy $D = 2$. In order to be able to compare theory and experiment in the same graph, we divide the experimental densities of carrier types e_1 and e_2 by $D = 2$ in Figs. 4(a) and 4(b).

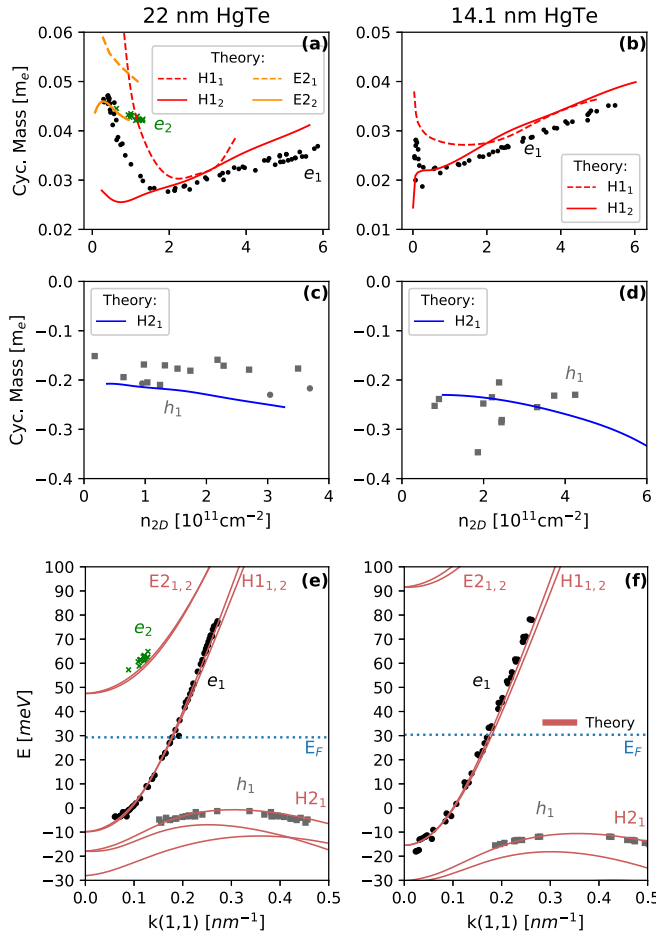


FIG. 4. Comparison of experimental data with $\mathbf{k} \cdot \mathbf{p}$ model calculations. Contrary to Fig. 3, the cyclotron masses are plotted as a function of the density. (a) Electronlike and (c) holelike carrier types corresponding to the 22-nm sample. (b) Electronlike and (d) holelike carrier types detected in the 14.1-nm sample. Filled symbols, experimental values; solid lines, theory. (e, f) Band structures of both samples along the (1,1) direction corresponding to $n_{2D} \approx 2.5 \times 10^{11} \text{ cm}^{-2}$ per each band, $H1_1$ and $H1_2$. Symbols, experimental data obtained from the cyclotron mass; solid lines, predictions of the $\mathbf{k} \cdot \mathbf{p}$ model.

The comparison between experimental points and theory allows us to recognize the carrier type \mathbf{e}_1 as the fingerprint of the first conduction $H1$ band since the corresponding data seem to match with the mean value of $H1_1$ and $H1_2$. We note that the splitting of these two spin-polarized states was observed at higher densities in the SdH analysis of the 14.1-nm sample, which is given in the Supplemental Material [25].

In the case of the 22-nm sample, the data suggest that charge carrier type \mathbf{e}_2 is linked to the second conduction band $E2$. Carrier type \mathbf{e}_2 cannot be linked to an individual spin-polarized subband due to the measured double degeneracy of the mode.

As shown in Figs. 4(c) and 4(d), carrier type \mathbf{h}_1 corresponds to the first valence bands ($H2_1$) in the systems, i.e., the spin-polarized hole band with the two symmetrical islands in the (k_x, k_y) plane of the band structure. Similarly to previous results [15], the theoretical hole mass slightly decreases

with the carrier concentration. This trend is supported by the scattering of the experimental points for the 22-nm sample, however, data for the thinner sample do not provide the accuracy for such a conclusion.

C. Band structure of the HgTe 2D semimetal

According to the identification of the carrier types in the previous section and in the SdH data, we assume the spin degeneracy $D = 2$ for \mathbf{e}_1 in both samples and $D = 2$ for \mathbf{h}_1 which corresponds to its double valley degeneracy [15,25,27,28]. The position of the experimentally reconstructed valence band maximum was shifted to the value provided by the theoretical model. As pointed out in the Appendix, Sec. 4, for holelike carrier types we calculate the \mathbf{k} vector along the (1,1) direction as $k = \sqrt{2}k_0 \pm k_{\text{eff}}$ with $k_{\text{eff}} = \sqrt{2\pi n}$. In the case of the 22-nm sample, carrier type \mathbf{e}_2 is assumed to be spin degenerate with $D = 2$.

The experimental band dispersions, calculated as described in the Appendix, Sec. 4, are shown in Figs. 4(e) and 4(f) as filled symbols. Direct integration fails to provide the absolute energy position of the bands. Since we assume that the gate voltage defines a constant Fermi level in the film, the bands are vertically aligned to each other by referring to the gate voltage at which they were mutually detected.

As discussed in the Appendix, Sec. 5, varying the total charge density n_{tot} by the gate voltage in an asymmetric system results in a variation of the corresponding band structure. While these effects play a major role in thicker samples [17], in our case, the differences between band structures calculated at boundary values of n_{tot} are not significant at the accessible energy resolution. Therefore the experimental results are compared to a single theoretical band structure, which was obtained at a total density $n_{\text{tot}} = 5 \times 10^{11} \text{ cm}^{-2}$, i.e., $n_{2D} \approx 2.5 \times 10^{11} \text{ cm}^{-2}$ per each band, $H1_1$ and $H1_2$, with the Fermi levels as indicated in Figs. 4(e) and 4(f). According to the theory estimates for the (0,1) direction, the first valence subband lies ~ 5 meV lower than along the (1,1) direction. Although seeing these maxima in the cyclotron analysis would be very interesting, we cannot reach them in the present experiment. Therefore, we show the (1,1) cut only, where the valence band is reached.

As clearly shown, the first conduction band, $H1$, is formed by carrier type \mathbf{e}_1 in both samples. The experimental resolution of the CR analysis did not allow us to observe the spin-splitting of the $H1$ band. We note that the steeper slope of the experimental points \mathbf{e}_1 at higher energies is probably a result of stronger structure inversion asymmetry at high gate voltages [17]. At low energies, carrier type \mathbf{h}_1 nicely overlaps with the valence band $H2_1$, which is spin-polarized and double-valley degenerate. The \mathbf{e}_2 carrier type, detected in the 22-nm sample, corresponds to the $E2$ band, and similarly to \mathbf{e}_1 , the experiment showed the spin-degenerate character of this band.

III. CONCLUSIONS

We have presented a CR study of two semimetallic HgTe samples with thicknesses of 14.1 and 22 nm in the sub-THz frequency range. The quasiclassical approach is utilized to reconstruct the parameters of the charge carriers, which is supported by the linearity of the cyclotron frequency in ex-

ternal magnetic fields. With the help of $\mathbf{k} \cdot \mathbf{p}$ models of the electronic configurations of both samples, several CR modes are recognized as fingerprints of the first valence band and first and second conduction bands. The results show a good overlap with the predictions of the $\mathbf{k} \cdot \mathbf{p}$ theory. The outcome of the CR analysis was also supported by a Shubnikov–de Haas analysis of the field-dependent capacitance measurements. The experimentally obtained band structure showed an overlap of ~ 5 – 10 meV between the first conduction and the first valence band, in turn confirming the existence of a semimetallic state in HgTe QWs in this range of thicknesses. Furthermore, the results confirm the anomalous twofold valley degeneracy of the first holelike valence band.

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APPENDIX: MATERIALS AND METHODS

1. Samples

Two CdHgTe/HgTe/CdHgTe quantum wells with 14.1- and 22-nm-thick HgTe layers were grown by molecular beam epitaxy on GaAs substrates [29,30] with a (013) surface orientation. A 6- μm -thick CdTe buffer layer between the layered structure and the substrate ensured that the lattice variation did not change abruptly, which resulted in high electron mobilities, $\mu \sim 2 \times 10^5$ cm²/V s. For the optical experiments, 5 \times 5 mm plates were cut from the wafer. On top, the structure was covered with a multilayered insulator, SiO₂/Si₃N₄, and a metallic Ti-Au layer, which acted as a semitransparent gate electrode. The gate was grown in a crosslike shape in order to cover the center of the sample for THz transmission measurements and to allow four electrical contacts at the corners of the sample for simultaneous transport measurements.

2. Technique

The CR response in the investigated systems was studied using magneto-optical transmission technique with controlled polarization of light [31,32]. Backward-wave oscillators were employed to produce continuous monochromatic light in the frequency range 100–1000 GHz. The polarization of the incident radiation was set to be circular, which in turn allows observation of either electron or hole CRs, depending on the sign of the applied magnetic field. An external magnetic field was provided by a split-coil superconducting magnet and was applied parallel to the \mathbf{k} vector of the THz radiation, i.e., in the Faraday geometry. The experiments were conducted with a sweeping magnetic field at various fixed frequencies of incident radiation. In addition, frequency-dependent spectra in a zero magnetic field were measured. All experiments were done at the lowest temperature of our spectrometer, $T = 1.8$ K.

3. Cyclotron resonance

For circularly polarized radiation the Drude model for dynamical conductivity in the quasiclassical approximation [17,33] can be written as

$$\sigma_+ = \sum_j \frac{\sigma_{0,j}}{1 - i\tau_j(\omega + \Omega_{c,j})}, \quad (\text{A1})$$

where for each active carrier type $\sigma_{0,j} = n_j e^2 \tau_j / m_{c,j}$ is the 2D DC conductivity, $\Omega_{c,j} = eB / m_{c,j}$ is the resonance frequency, n_j is the 2D density, τ_j is the intrinsic scattering time, $m_{c,j}$ is the effective cyclotron mass, and e is the electron charge. The transmission of circularly polarized radiation through a metallic film with a single charge carrier and a thickness of $d \ll \lambda$ can be calculated as [34]

$$t_+ = 1 - \frac{i}{\tau_{\text{SR}}} \frac{1}{(\omega + i\Gamma) - \Omega_c}. \quad (\text{A2})$$

Here, $\Gamma = 1/\tau + 1/\tau_{\text{SR}}$ corresponds to the "total" scattering rate, $1/\tau$ is the transport scattering rate, $1/\tau_{\text{SR}} = ne^2 Z_0 / 2m_c$ is the superradiant damping [35], and Z_0 is the impedance of the free space. Equation (A2) serves as a convenient demonstration that a resonant response of the system with a single charge carrier is expected in transmission spectra. However, for a proper analysis of the experimental data, we employ a model with multiple carrier types in the system, which also takes into account the reflections within the substrate. The procedure utilizes algebra similar to that described previously [17,34,36].

4. Reconstruction of the band structure

In the quasiclassical approximation, transitions between several Landau levels overlap and the cyclotron frequency Ω_c can be written in terms of the cyclotron mass as [37]

$$m_c \equiv \frac{eB_r}{\Omega_c} = \frac{\hbar^2}{2\pi} \frac{\partial A}{\partial E} \Big|_{E=E_F}. \quad (\text{A3})$$

Here B_r is the resonance magnetic field, A is the area in the reciprocal space enclosed by the contour of the constant energy E , and E_F is the Fermi energy. If the Fermi area is magnetic field independent, at least at low fields, Eq. (A3) leads to a linear relation between Ω_c and B_r independently of the form of the dispersion relations.

In further approximations for 2D materials, the local isotropy of the bands can be assumed. This leads to a simple relation between the Fermi vector k_F and the Fermi area, $A = \pi k_F^2$. Then Eq. (A3) can be rewritten as [17]

$$\frac{\partial E}{\partial k} \Big|_{E=E_F} = \frac{\hbar^2 k_F}{m_c} \quad (\text{A4})$$

and, thus, can be directly integrated to obtain $E(k)$.

We note, however, that especially for the hole islands the isotropic approximation does not hold. Nevertheless, at lower hole concentrations the islands can be approximated as circles [see Fig. 1(b)] with an effective radius k_{eff} related to the Fermi surface area as $A = \pi k_{\text{eff}}^2$. Of course, the exact relation between A and k_{eff} can be calculated from the theory. We believe, however, that a reasonable picture of the band structure can be obtained within this approximation as well. A direct comparison between theory and experiment can be done

using an approximation-independent plot of cyclotron masses vs density. This presentation is not sensitive to approximations done in Eq. (A4).

To calculate the experimental band structure via Eq. (A4), the charge density of electrons is transferred to the electron momentum using the relation $k = \sqrt{4\pi n/D}$, with D being the degeneracy of the band. In the case where the Fermi area is shifted to a point \mathbf{k}_0 in the Brillouin zone, the wave vector in Eq. (A4) is calculated as $\mathbf{k}_{\text{eff}} = \mathbf{k} - \mathbf{k}_0$. Here \mathbf{k}_0 has to be taken from, e.g., model calculations. In a further improvement, deviations of the Fermi surface from the circle can be taken into account. However, these details are beyond the accuracy of the present experiment.

5. Theoretical band structure

The band structure of the strained HgTe QWs has been calculated using the eight-band $\mathbf{k} \cdot \mathbf{p}$ model in an envelope function approach which includes the coupling between the lowest conduction band Γ_6^c and the topmost valence bands Γ_8^v and Γ_7^v . Further details of the model can be found in Ref. [38], where specific $\mathbf{k} \cdot \mathbf{p}$ parameters are given. Assuming that HgTe QWs are grown on a CdTe substrate, strain effects due to the lattice mismatch between HgTe and CdTe were taken into account applying the Bir-Pikus formalism [39].

A generalization of the $\mathbf{k} \cdot \mathbf{p}$ model for structures grown on high-index planes [40] has been used to include additional terms in the Hamiltonian that are responsible for coupling of states in the (013) growth direction.

The calculations have been done taking into account the structure and bulk inversion asymmetry [41]. Whereas in the experiment the carrier density in the QW is tuned by the gate voltage, in the model the variation of the doping in the top barrier is assumed, while the doping in the barrier on the substrate side is taken to be constant. Asymmetric barrier doping results in an asymmetric distribution of the Hartree potential, which has been determined by solving self-consistently the eigenvalue problem and the Poisson equation for the 2D charge carriers in the QW [38]. The bulk inversion asymmetry of the zinc-blende crystal structure gives rise to the Dresselhaus spin-orbit interaction. Here, the bulk inversion asymmetry terms were linear in momentum for valence bands Γ_8^v and Γ_7^v , while the contribution from the coupling between the conduction and the valence bands was quadratic in momentum [41]. The following bulk inversion asymmetry parameters, taken from Refs. [41–43], were used: $C_k(\text{HgTe}) = -7.46 \text{ meV nm}$, $B_{8v}^+(\text{HgTe}) = -200 \text{ meV nm}^2$, $B_{8v}^-(\text{HgTe}) = 10 \text{ meV nm}^2$, $B_{7v}(\text{HgTe}) = -200 \text{ meV nm}^2$, $C_k(\text{CdTe}) = -2.34 \text{ meV nm}$, $B_{8v}^+(\text{CdTe}) = -224.1 \text{ meV nm}^2$, $B_{8v}^-(\text{CdTe}) = -6.347 \text{ meV nm}^2$, $B_{7v}(\text{CdTe}) = -204.7 \text{ meV nm}^2$.

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